imall

Chipsmall Limited consists of a professional team with an average of over 10 year of expertise in the distribution of electronic components. Based in Hongkong, we have already established firm and mutual-benefit business relationships with customers from, Europe, America and south Asia, supplying obsolete and hard-to-find components to meet their specific needs.

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EPC8002

Halogen-Free

EPC8002 – Enhancement Mode Power Transistor

 V_{DS} , 65 V $\mathrm{R}_{\mathrm{DS(on)}}$, $\,480\,\mathrm{m}\Omega$ I_{D} , 2 A

New Product

Gallium Nitride is grown on Silicon Wafers and processed using standard CMOS equipment leveraging the infrastructure that has been developed over the last 55 years. GaN's exceptionally high electron mobility and low temperature coefficient allows very low $R_{DS(on)}$, while its lateral device structure and majority carrier diode provide exceptionally low Q_G and zero Q_{RR} . The end result is a device that can handle tasks where very high switching frequency, and low on-time are beneficial as well as those where on-state losses dominate.

Maximum Ratings				
V	Drain-to-Source Voltage (Continuous)		V	
V _{DS}	V _{Ds} Drain-to-Source Voltage (up to 10,000 5 ms pulses at 150° C)		v	
	$I_{D} \qquad \frac{\text{Continuous } (T_{A} = 25^{\circ}\text{C}, R_{\theta JA} = 37^{\circ}\text{C/W})}{\text{Pulsed } (25^{\circ}\text{C}, T_{Pulse} = 300 \ \mu \text{s})}$		٨	
I _D			A	
V	Gate-to-Source Voltage	6 V		
V _{GS}	Gate-to-Source Voltage	-4	v	
T,	T, Operating Temperature		°C	
T _{STG}	Storage Temperature	-40 to 150		



EPC8002 eGaN FETs are supplied only in passivated die form with solder bars Die Size: 2.1 mm x 0.85 mm

EFFICIENT POWER CONVERSION

Applications

RoHS P

- Ultra High Speed DC-DC Conversion
- RF Envelope Tracking
- Wireless Power Transfer
- Game Console and Industrial Movement Sensing (LiDAR)

Benefits

- Ultra High Efficiency
- Ultra Low R_{DS(on)}
- Ultra Low Q_G
- Ultra Small Footprint

www.epc-co.com/epc/Products/eGaNFETs/EPC8002.aspx

PARAMETER		TEST CONDITIONS	MIN	ТҮР	МАХ	UNIT	
Static Characte	Static Characteristics (T_j = 25°C unless otherwise stated)						
BV _{DSS}	Drain-to-Source Voltage	$V_{GS}{=}0V,I_{D}{=}125\mu A$	65			V	
I _{DSS}	Drain Source Leakage	$V_{DS} = 52 V, V_{GS} = 0 V$		20	100	μA	
1	Gate-to-Source Forward Leakage	$V_{GS} = 5 V$		0.1	1	mA	
I _{GSS}	Gate-to-Source Reverse Leakage	$V_{GS} = -4 V$		20	100	μA	
$V_{GS(TH)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 0.1 \text{ mA}$	0.8	1.4	2.5	V	
R _{DS(ON)}	Drain-Source On Resistance	$V_{GS} = 5 \text{ V}, \text{ I}_{D} = 0.5 \text{ A}$		380	480	mΩ	
V _{SD}	Source-Drain Forward Voltage	$I_{s} = 0.4 \text{ A}, V_{GS} = 0 \text{ V}$		2.6		V	

Specifications are with substrate shorted to source where applicable.

Thermal Characteristics				
		ТҮР	UNIT	
R _{eJC}	Thermal Resistance, Junction to Case	8.2	°C/W	
R _{eJB}	Thermal Resistance, Junction to Board	16	°C/W	
R _{eja}	Thermal Resistance, Junction to Ambient (Note 1)	82	°C/W	

Note 1: R_{uA} is determined with the device mounted on one square inch of copper pad, single layer 2 oz copper on FR4 board. See http://epc-co.com/epc/documents/product-training/Appnote_Thermal_Performance_of_eGaN_FETs.pdf for details.

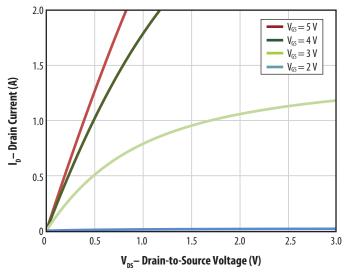
eGaN® FET DATASHEET

EPC8002

	PARAMETER	TEST CONDITIONS	MIN	ТҮР	МАХ	UNIT
ynamic Chara	cteristics (T _J = 25°C unless otherwise s	stated)				
C _{ISS}	Input Capacitance			20	24	
C _{RSS}	Reverse Transfer Capacitance	$V_{DS} = 32.5 V, V_{GS} = 0 V$		0.12	0.18	7
Coss	Output Capacitance			6.7	10	
C _{OSS(ER)}	Effective Output Capacitance, Energy Related (Note 2)	$V_{DS} = 0$ to 32.5 V, $V_{GS} = 0$ V		8.9		— pF
C _{OSS(TR)}	Effective Output Capacitance, Time Related (Note 3)	$v_{DS} = 0.0032.3 v, v_{GS} = 0.0$		10		
R_{G}	Gate Resistance			0.3		Ω
Q _G	Total Gate Charge	$V_{DS} = 32.5 \text{ V}, V_{GS} = 5 \text{ V}, I_D = 0.5 \text{ A}$		133	167	
Q _{GS}	Gate-to-Source Charge			57		1
Q_{GD}	Gate-to-Drain Charge	V_{DS} = 32.5 V, I _D = 0.5 A		15	26	pC
$Q_{G(TH)}$	Gate Charge at Threshold			46		7 '
Q _{oss}	Output Charge	$V_{DS} = 32.5 \text{ V}, V_{GS} = 0 \text{ V}$		334	500	7
Q _{RR}	Source-Drain Recovery Charge			0		7

Note 2: $C_{OSSLERI}$ is a fixed capacitance that gives the same stored energy as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}. Note 3: $C_{OSSLTRI}$ is a fixed capacitance that gives the same charging time as C_{OSS} while V_{DS} is rising from 0 to 50% BV_{DSS}.

Figure 1: Typical Output Characteristics at 25°C





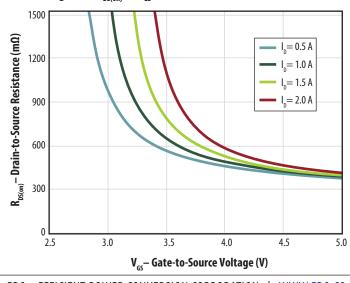
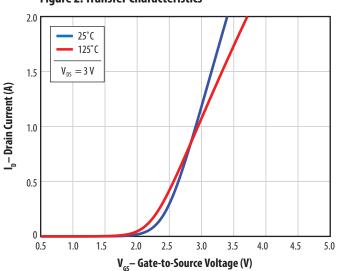
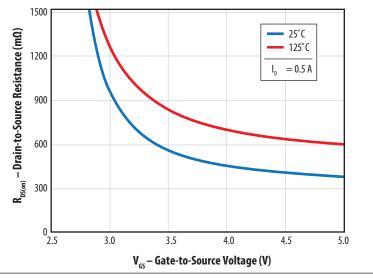


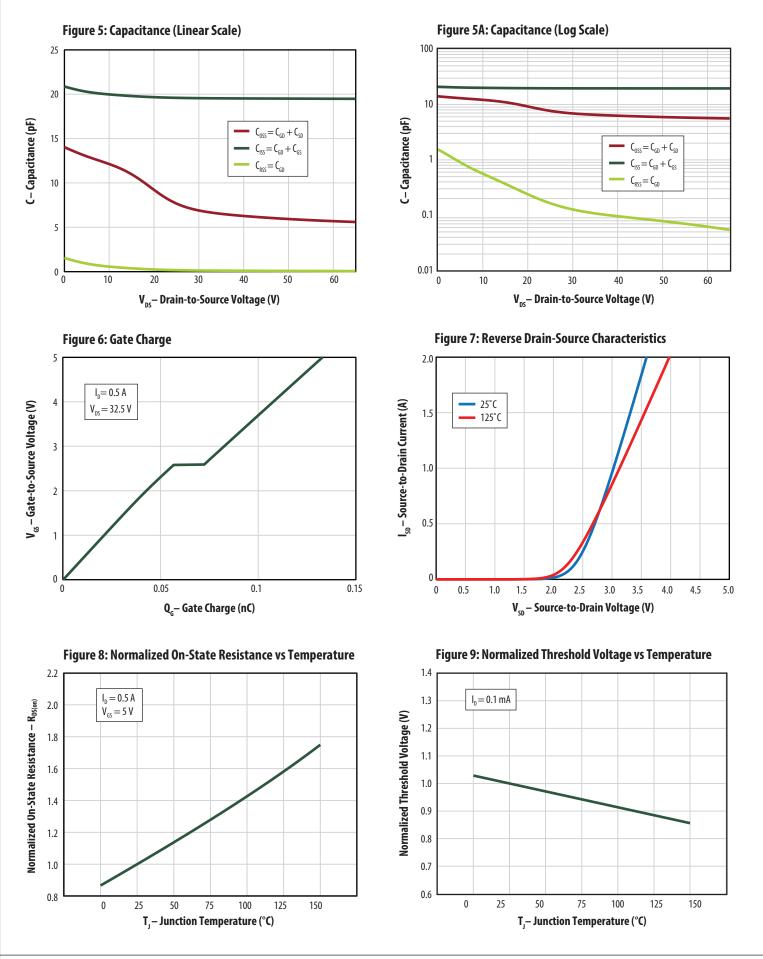
Figure 2: Transfer Characteristics

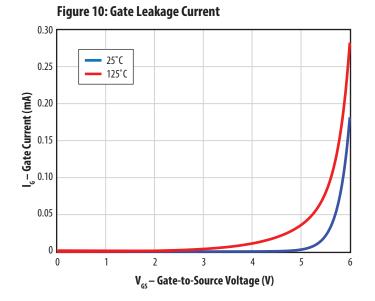


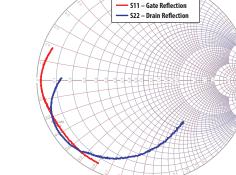




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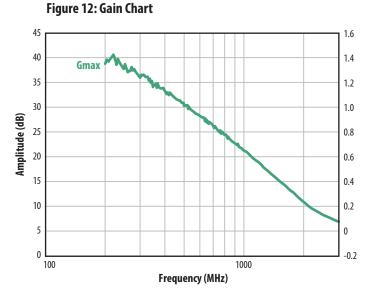




S-Parameter Characteristics $V_{GSQ} = 1.17$ V, $V_{DSQ} = 30$ V, $I_{DQ} = 0.2$ A

Pulsed Measurement, Heat-Sink Installed, $Z_0 = 50 \ \Omega$



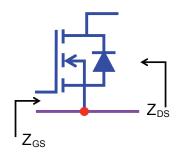


Frequency	Gate (Z _{GS})	Drain (Z _{DS})		
[MHz]	[Ω]	[Ω]		
200	3.09 - j29.97	63.13 - j71.32		
500	2.20 - j11.92	15.96 -j46.65		
1000	1.14 - j4.46	3.35 - j23.47		
1200	0.95 - j2.76	1.91 - j18.52		
1500	0.87 - j0.55	1.66 - j12.66		
2000	1.09 + j2.61	2.28 - j6.12		
2400	1.44 + j4.87	4.35 - j2.80		
3000	2.36 + j8.79	6.41 + j0.69		

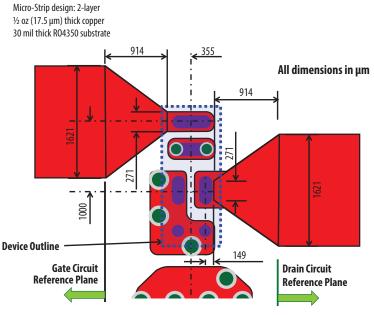
S-Parameter Table - Download S-parameter files at www.epc-co.com

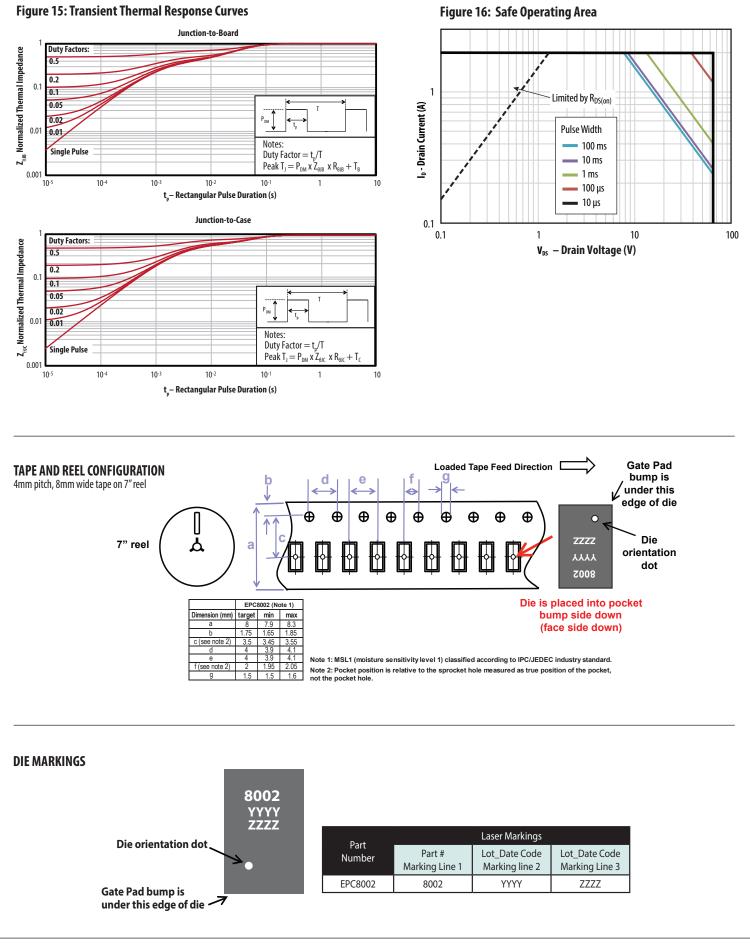
Figure 13: Device Reflection

Figure 11: Smith Chart



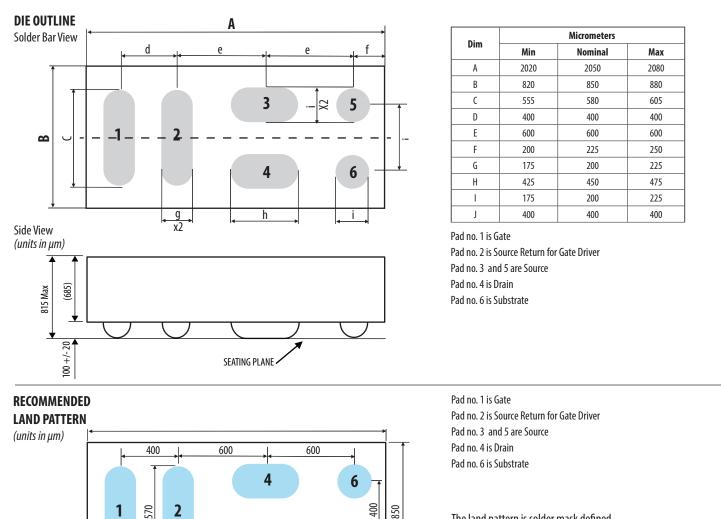






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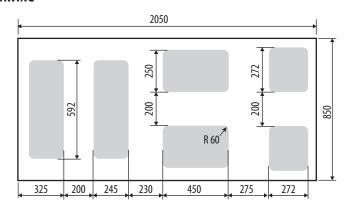


The land pattern is solder mask defined.

RECOMMENDED **STENCIL DRAWING**

190

(units in µm)



190

3

440

6

5

Recommended stencil should be 4 mil (100 µm) thick, must be laser cut, openings per drawing.

Intended for use with SAC305 Type 3 solder, reference 88.5% metals content.

Additional assembly resources available at: http://epc-co.com/epc/DesignSupport/AssemblyBasics.aspx

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U.S. Patents 8,350,294; 8,404,508; 8,431,960; 8,436,398; 8,785,974; 8,890,168; 8,969,918; 8,853,749; 8,823,012

Information subject to change without notice. Revised November, 2015

EPC8002